

Diamond Growth at Michigan State University

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NSCL / Michigan State University

3rd NoRHDia Workshop

GSI, August 2006



Methods of Diamond Growth

High-pressure, High-temperature (HPHT)

GE, Sumitomo, De Beers, Gemesis, **not at MSU**

Chemical Vapor Deposition (CVD)

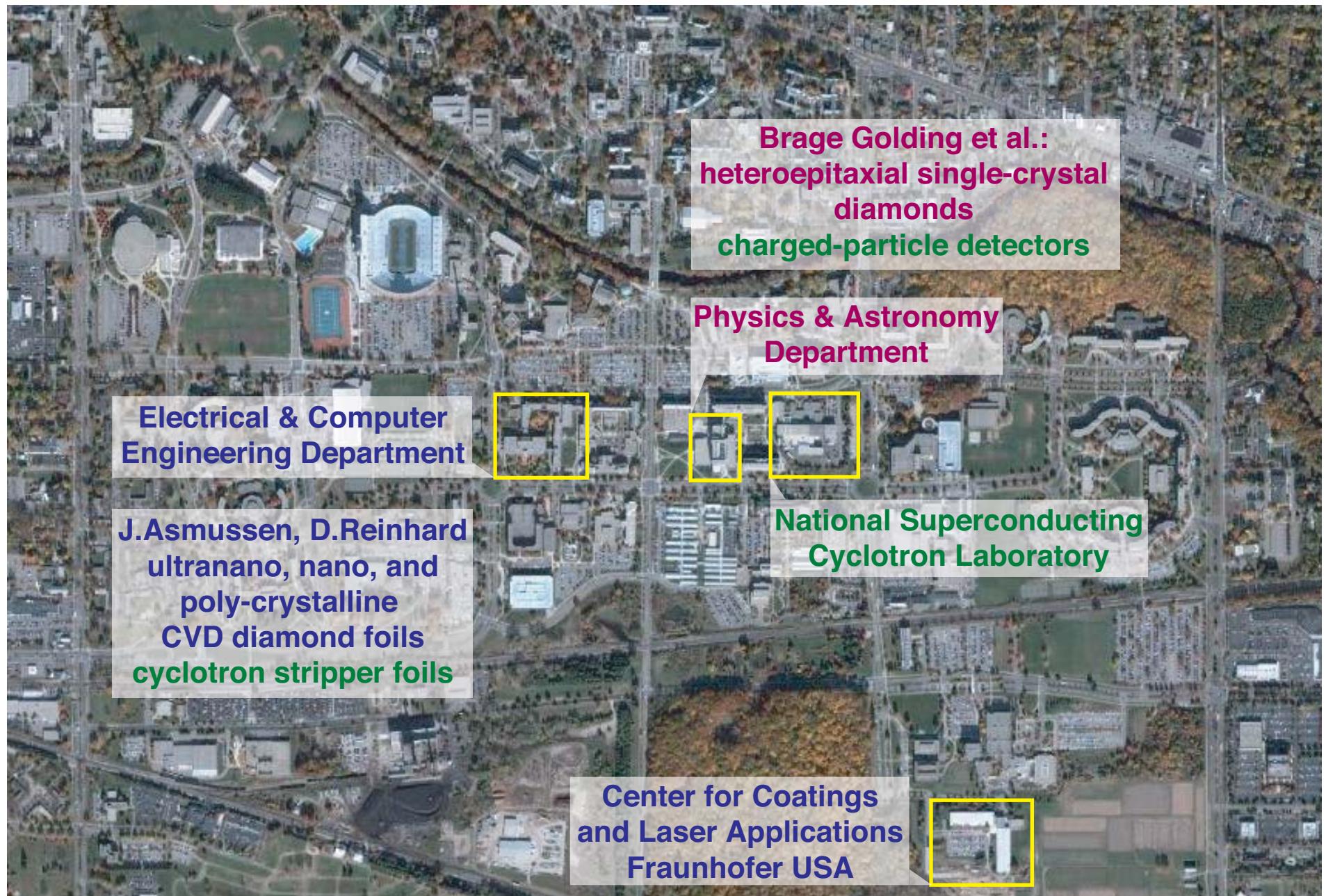
Microwave or hot-filament plasma

Methane and hydrogen, 800 C, 50 Torr

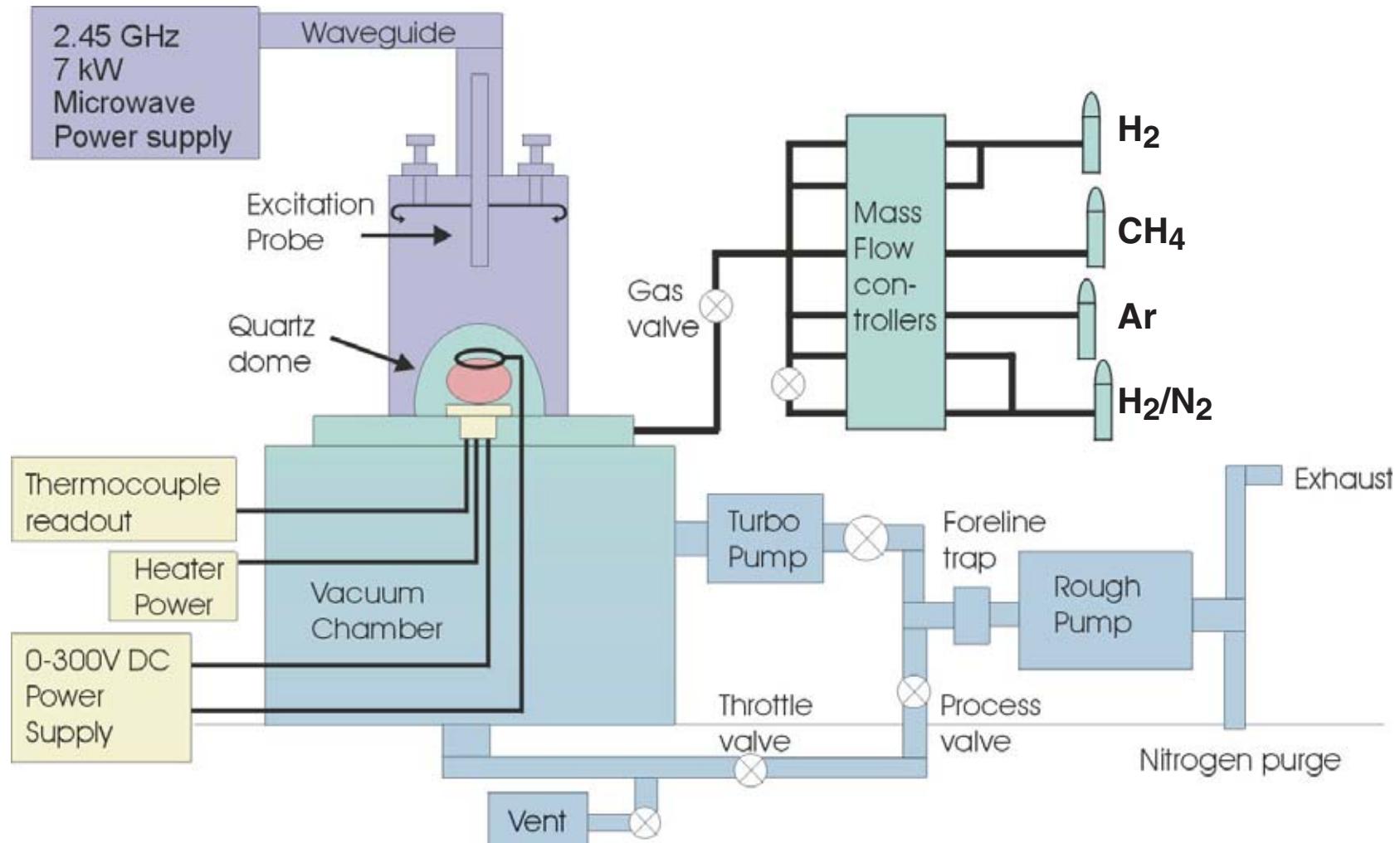
Homoepitaxial (diamond on diamond)

Heteroepitaxial (diamond on non-diamond)

Diamond Growth at Michigan State University



Microwave Plasma Chemical Vapor Deposition System



Growth of diamond on silicon wafers

Fabrication and Properties of Ultranano, Nano, and Polycrystalline Diamond Membranes and Sheets

D. K. Reinhard, J. Asmussen, et al.,
Michigan State University, Electrical & Computer Engineering Department &
Fraunhofer Center for Coating and Laser Applications

- **Polycrystalline:**
grain sizes measured in micrometers
- **Nanocrystalline:**
Sub-micron grains; grain sizes measured in hundreds of nanometers
- **Ultrananocrystalline:**
Grain sizes measured in tens of nm and smaller;
fabricated with Ar/CH₄ chemistry

Growth of diamond on silicon wafers

Nucleation on silicon wafers is facilitated by pre-treatment with diamond powder ($< 0.25\mu\text{m}$). (scratch-seeding stimulates diamond nucleation)

- **Polycrystalline:**

Diamond powder is mixed with resist and wafer is spin coated.

- **Nanocrystalline & Ultranananocrystalline:**

Diamond dry-polished with powder and cleaned.

D. K. Reinhard, et al., "Fabrication and properties of ultra-nano, nano, and polycrystalline Diamond Membranes and Sheets", AVS 50th International Symposium, November 2-7, 2003.

Growth of diamond on silicon wafers

Deposition Parameters:

poly-and nanocrystalline

- Pressure: 7 –15 torr (poly);
15 –35 torr(nano)
- Microwave Power: 700 W
- Typical Gas Flow Rates:
H₂ 200 sccm
CO₂ 8 sccm
CH₄ 3 sccm
- Substrate Temperature:
500 - 600°C (poly);
600 - 700°C (nano)

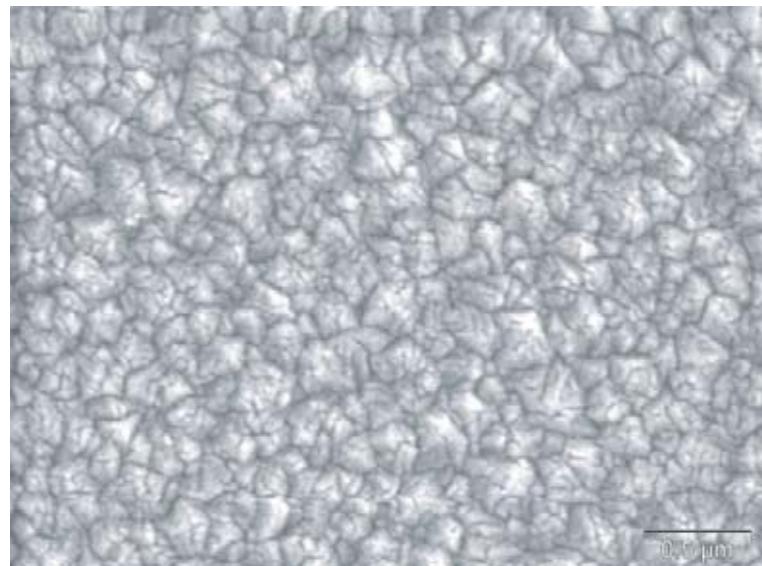
ultrananocrystalline

- Pressure: 120 torr
 - Microwave Power: 1.1 KW,
 - Typical Gas Flow Rates:
Ar 100 sccm
H₂ 1 to 4 sccm
CH₄ 1 sccm
 - Substrate Temperature:< 650 C.
- 3" wafer,
linear growth rate: 1 micron / hour

D. K. Reinhard, et al., "Fabrication and properties of ultra-nano, nano, and polycrystalline Diamond Membranes and Sheets", AVS 50th International Symposium, November 2-7, 2003.

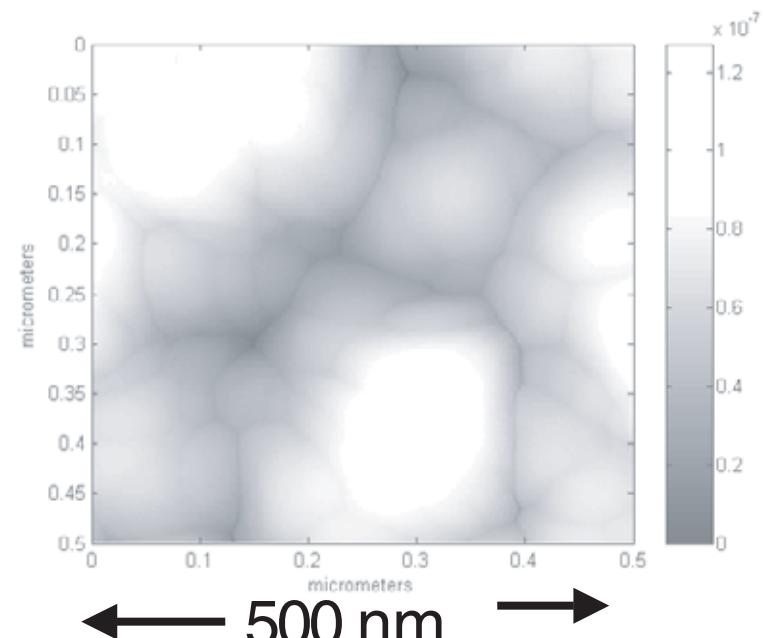
Nanocrystalline Diamond Film

FB16 SEM



↔
1 μm

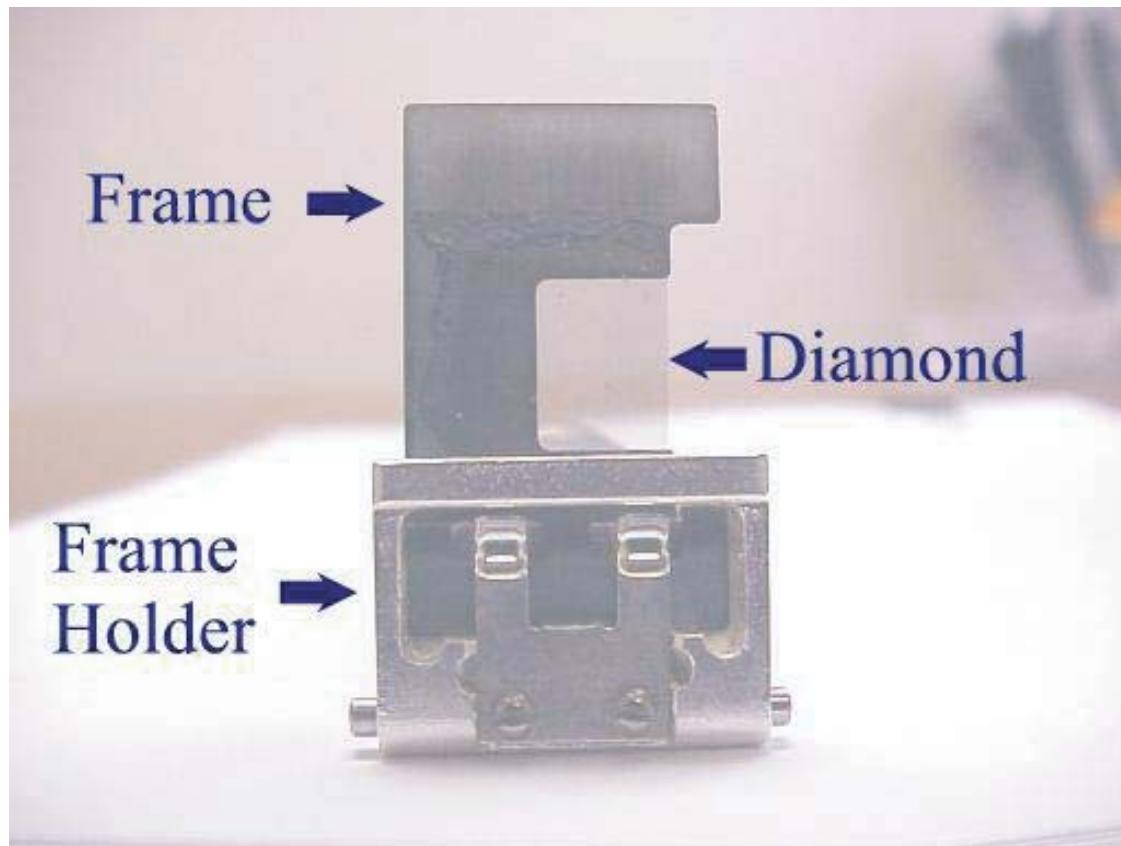
AFM



$\text{H}_2/\text{CO}_2/\text{CH}_4$ (sccm): 200/8/3. Power = 0.7 kW, P = 33 torr
Polished Seeding

D. K. Reinhard, et al., "Fabrication and properties of ultra-nano, nano, and polycrystalline Diamond Membranes and Sheets", AVS 50th International Symposium, November 2-7, 2003.

Cyclotron Stripper Foils



Nanocrystalline diamond foils mounted on 3-sided frame

used inside NSCL cyclotron as electron stripper foil for heavy ion beam

Heteroepitaxial Single Crystal Diamond

Growth:

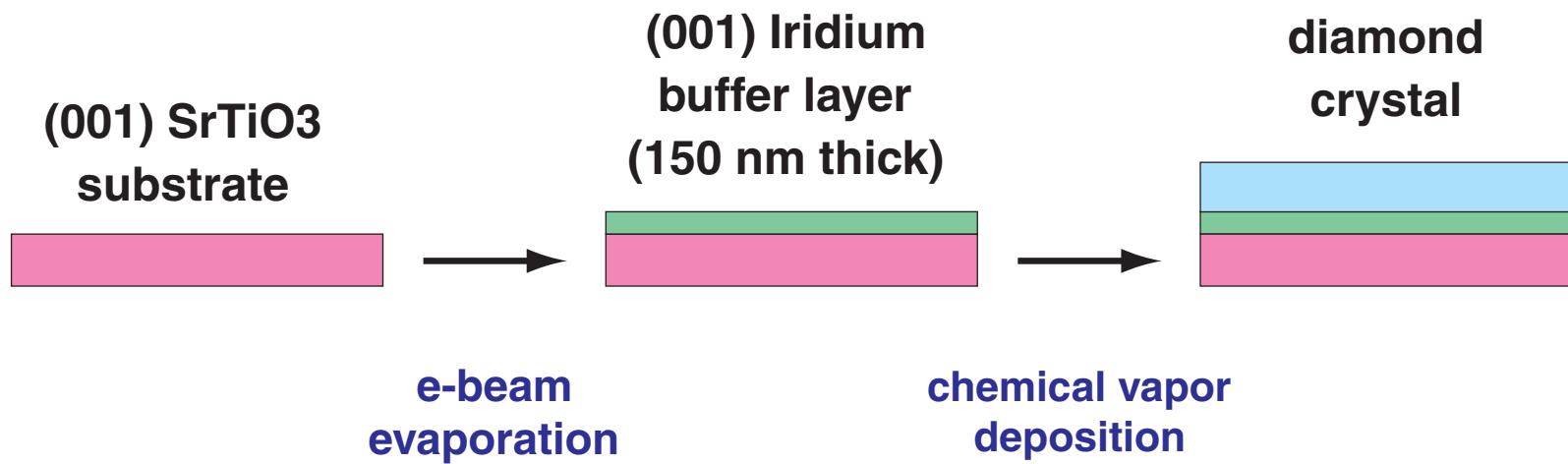
**Brage Golding,
C. Bednarski, M. Behravan, Z. Dai, A.-P. Li, M. Regmi**

Physics & Astronomy Department, MSU

Application at NSCL:

**diamond detectors for medium-energy heavy-ions,
timing and tracking applications**

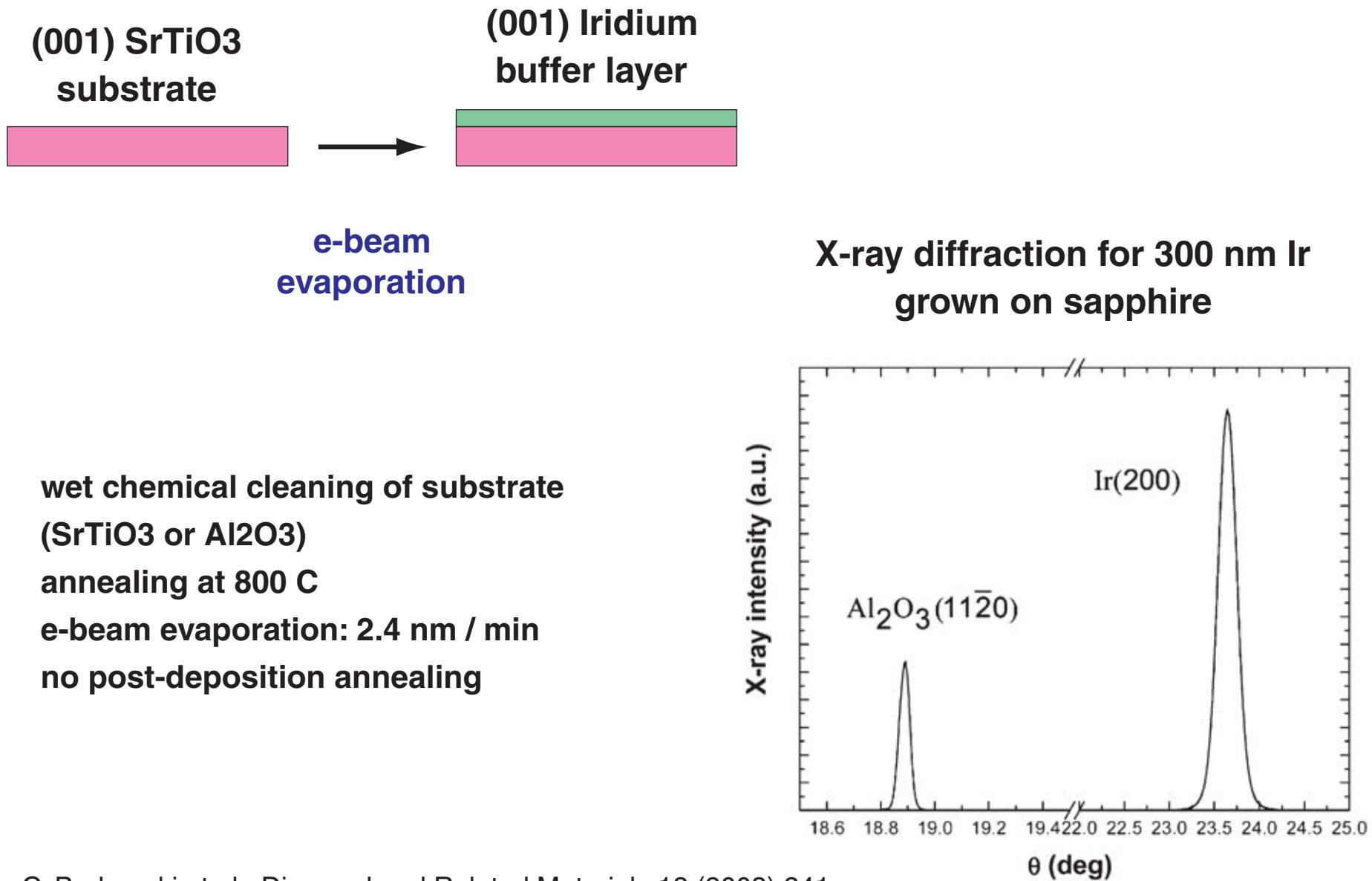
Heteroepitaxial Diamond Growth



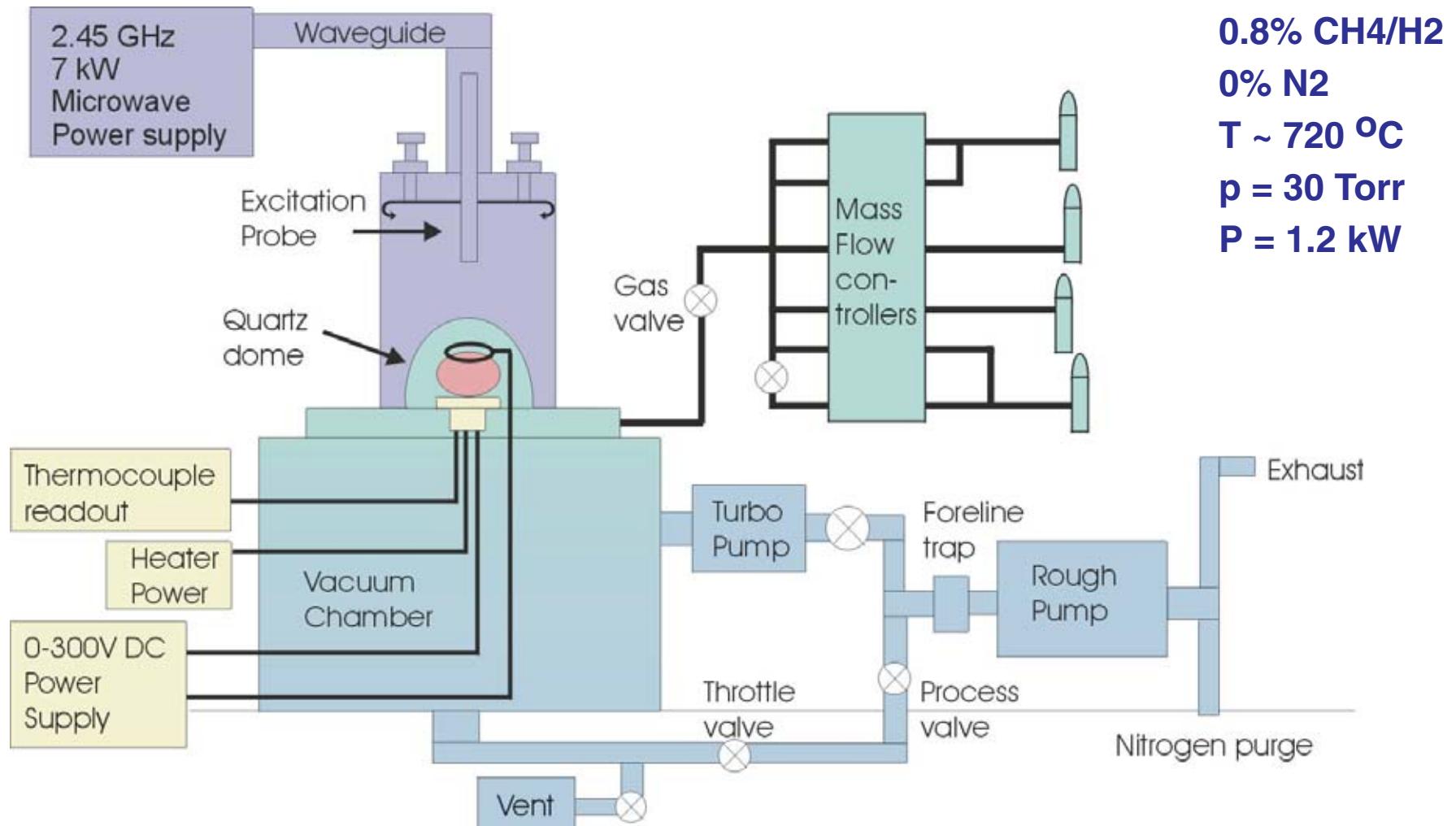
Material Properties of Substrates

Material	Crystal structure	Lattice constant [nm]	Melting point [C]	Thermal expansivity [10-6 K-1]
Diamond	cubic	0.3567	4027	1.5
Iridium	cubic	0.3839	2484	6.8
Al ₂ O ₃	hexagonal	a=0.4758 c=1.2991	2040	4.2 5.3
MgO	cubic	0.4216	2800	12.8
SrTiO ₃	cubic	0.3905	2080	10.3

Iridium Growth



CVD Process Parameters



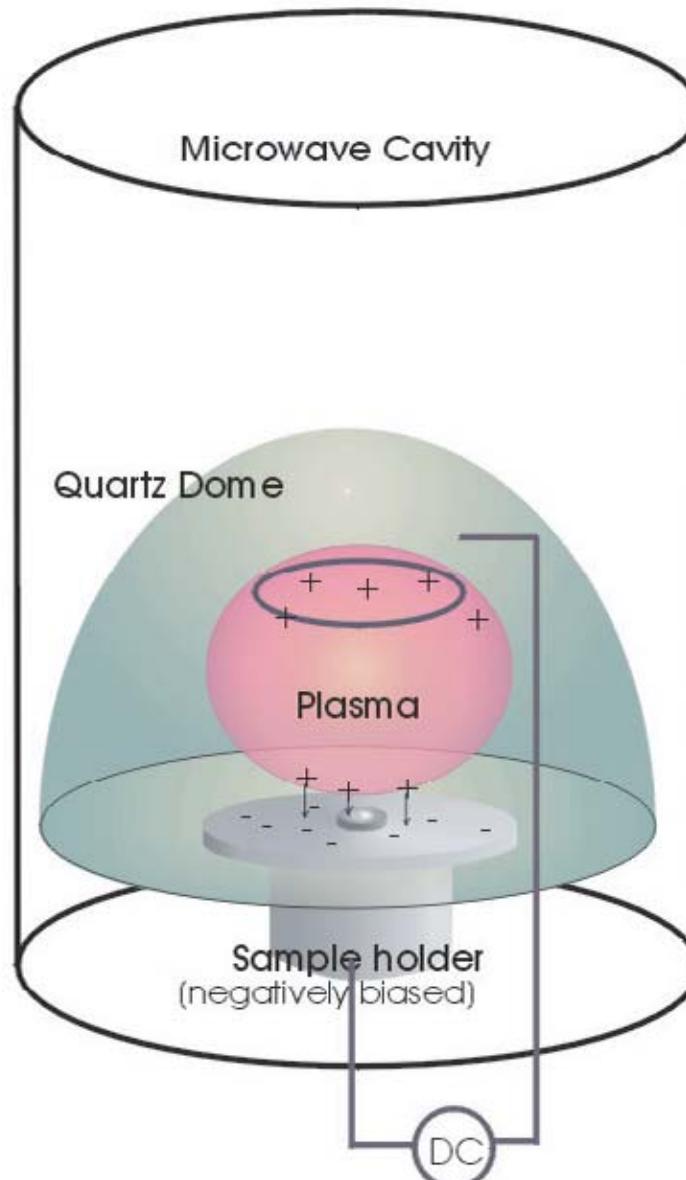
Nucleation Process

How do you induce diamond to start growing on a metal?

Schematic of biasing geometry during nucleation process

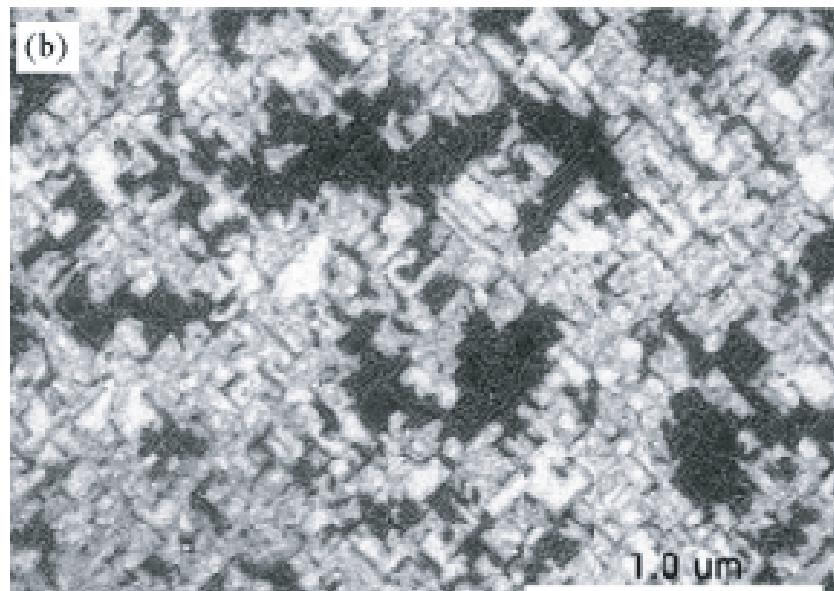
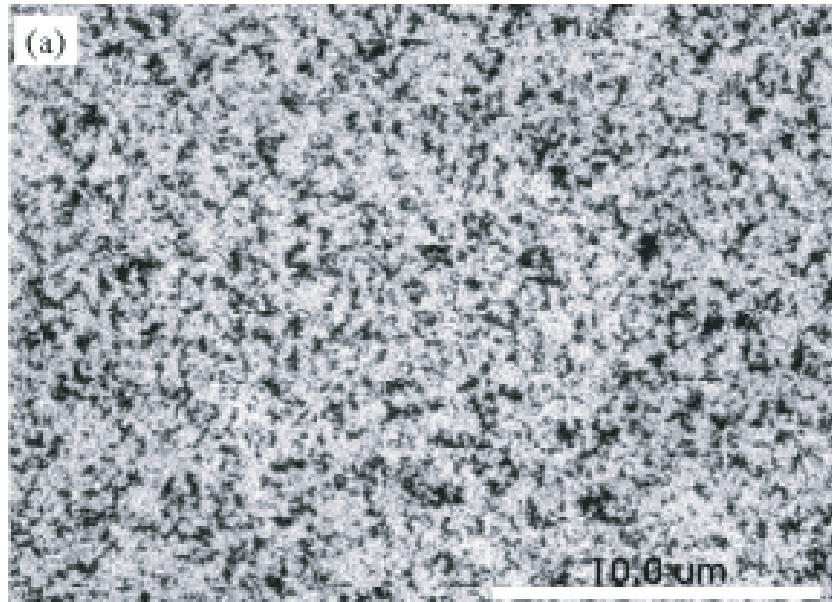
Nucleation occurs with terminating of biasing

With bias: carbon condense in highly excited non-equilibrium state
Removal of bias: rapid temperature quench initiating nucleation



bias voltage: -140 to 200 V

Deposition of Carbon on Ir (001)



Bias period: 20 min

bright regions are diamond-like carbon condensate

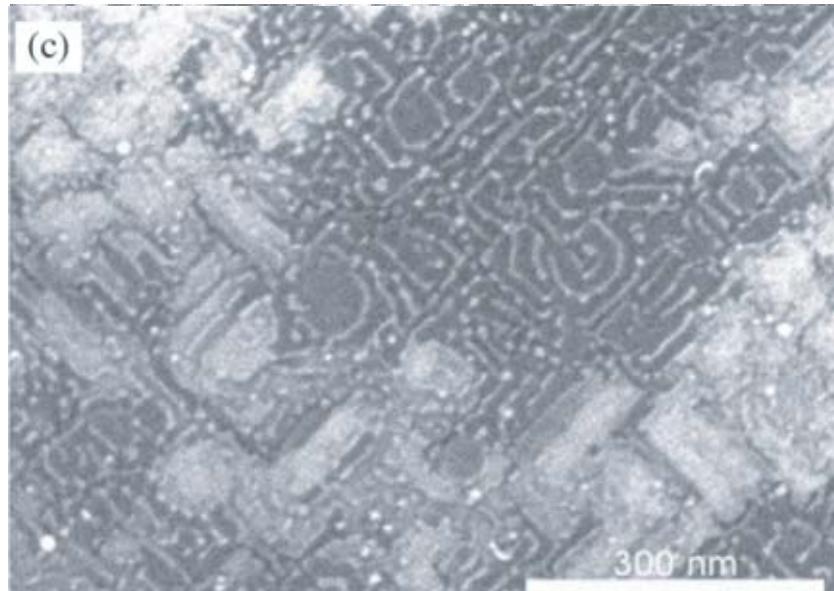
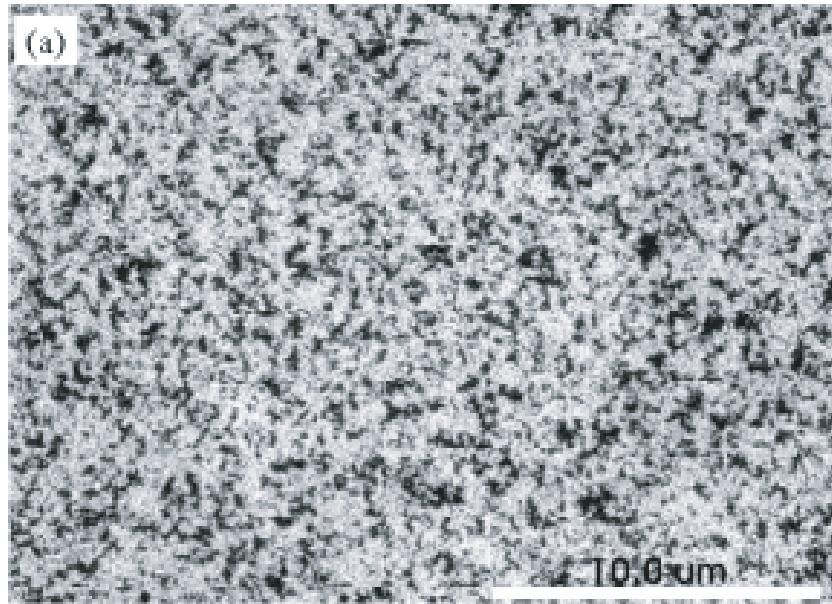
condensate covers 75% of surface

diffuse rectangular blocks of condensate

characteristic linear dimensions: 100-200 nm

boundaries parallel to in-plane Ir [110] directions

Deposition of Carbon on Ir (001)



Bias period: 20 min

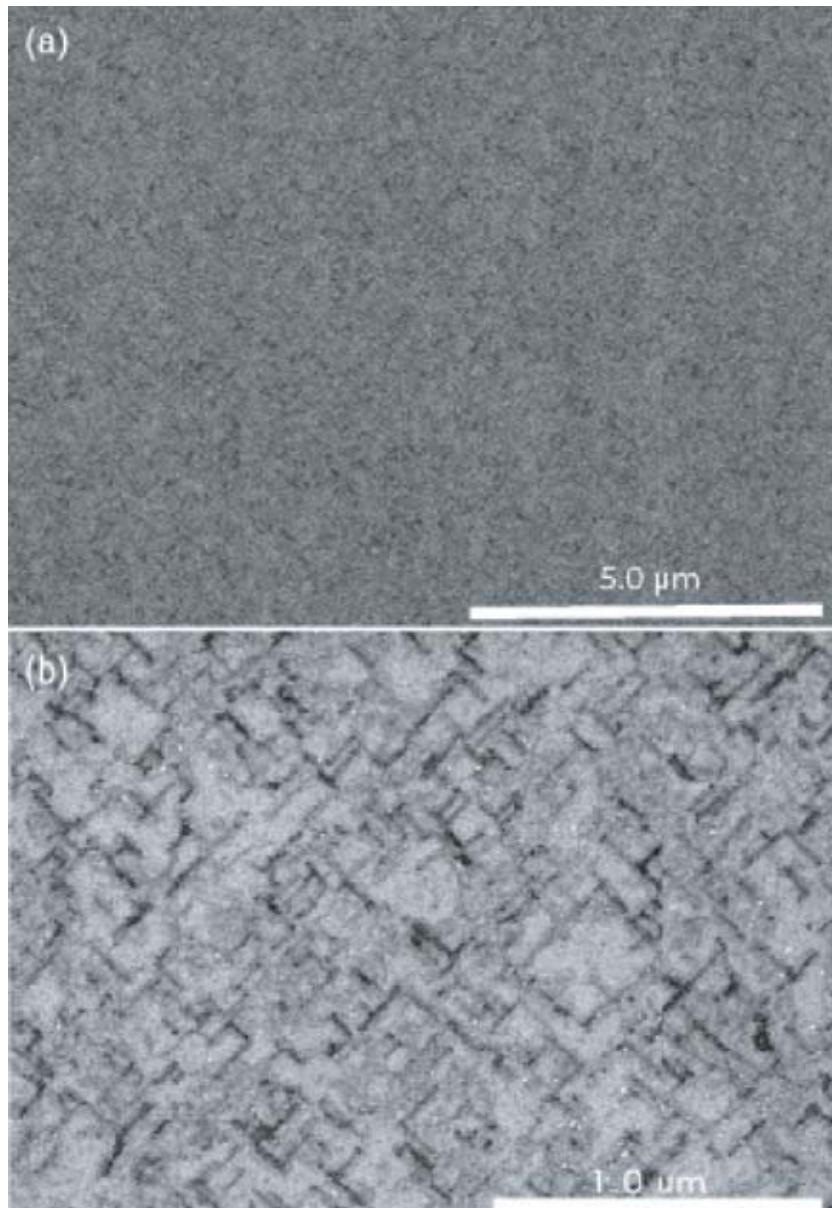
bright regions are diamond-like carbon condensate

condensate covers 75% of surface

higher magnification of low-density region:

diffuse condensate in the presence of decorated ridges and whorls of Ir surface

Deposition of Carbon on Ir (001)



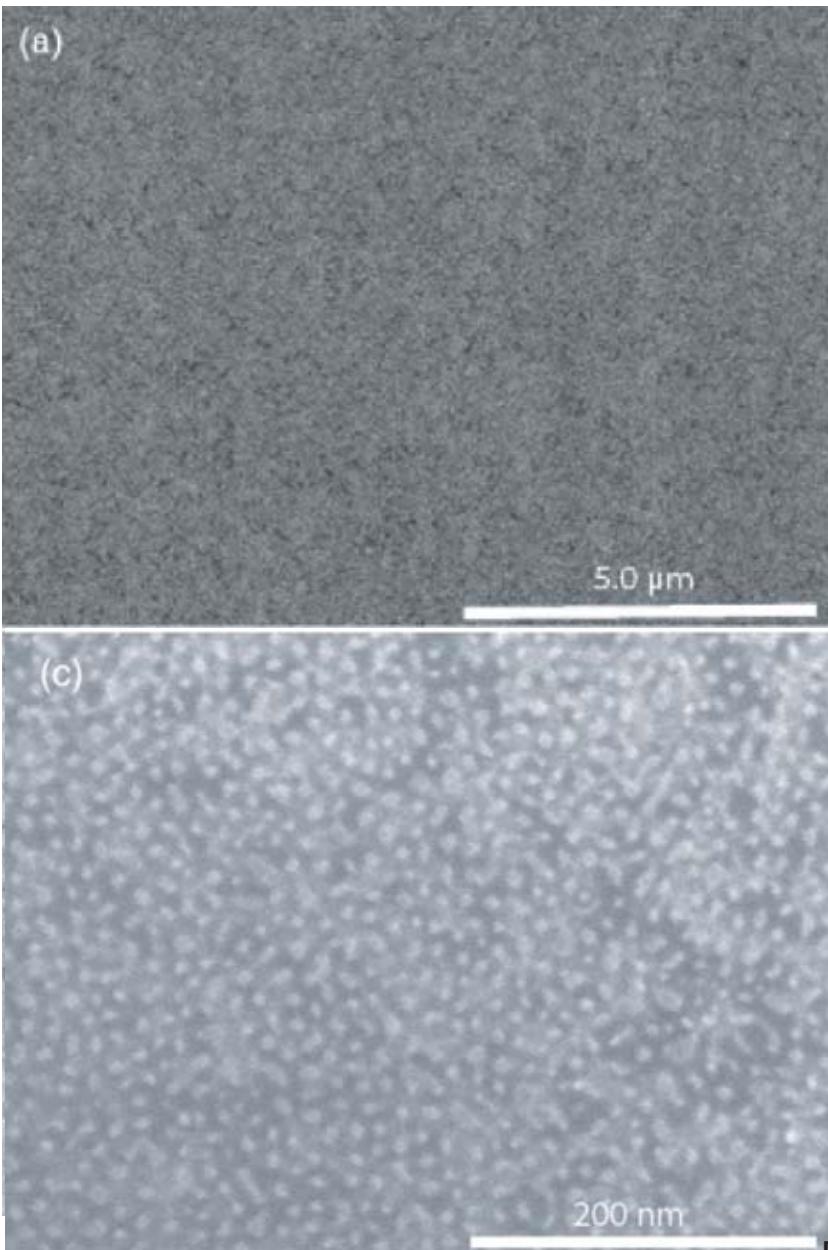
Bias period: 60 min

bright regions are diamond-like carbon condensate

condensate covers 82% of surface
increase of thickness of condensate

low -density region with <110> alignment

Deposition of Carbon on Ir (001)



Bias period: 60 min

bright regions are diamond-like carbon condensate

condensate covers 82% of surface
increase of thickness of condensate

higher magnification reveals diamond nanocrystallites

clusters with diameters near 7 nm
separation ~ twice diameter

Early Stages of Diamond Evolution

1. Bias

hot plasma discharge
highly excited carbon
condensate
deposition of sp₃ carbon

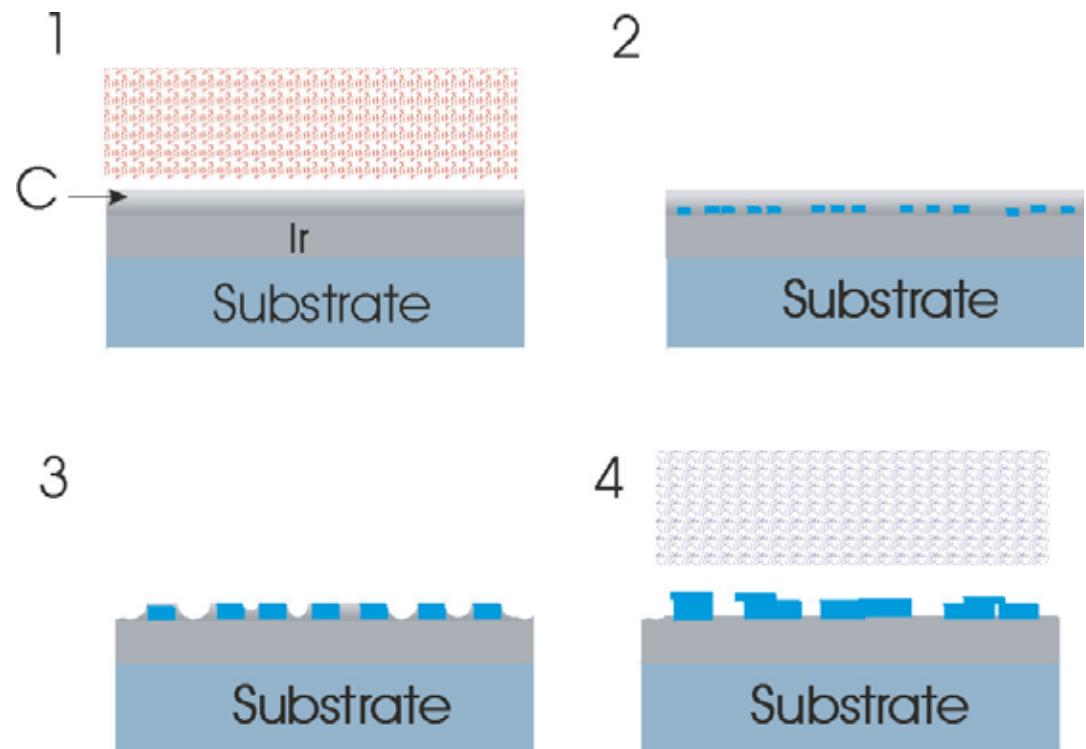
2. Quench

condensate cools rapidly
region of instability
appearance of nanocrystals

3. Growth from matrix

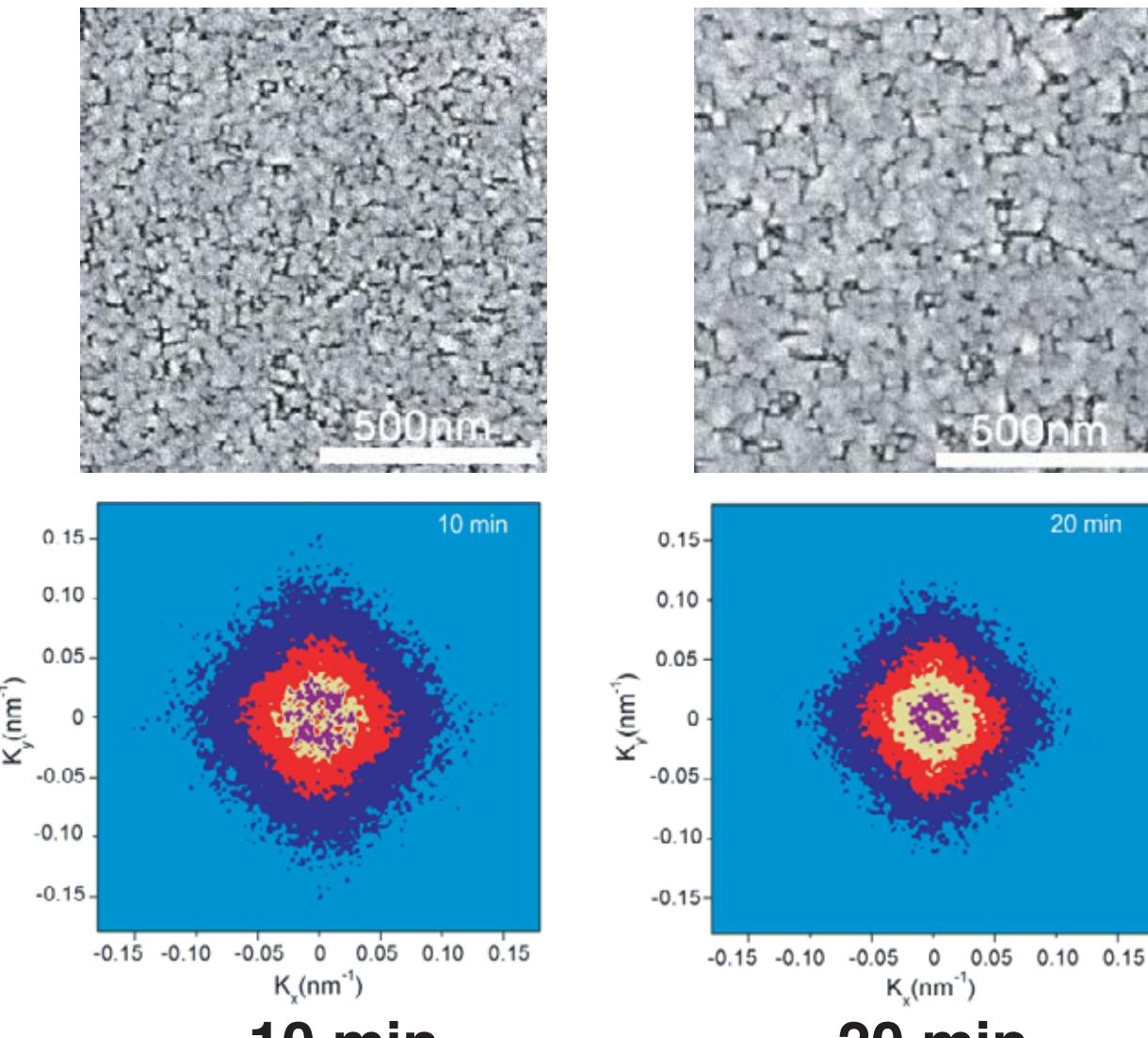
diamond is denser phase
than precursor ->
depletion of condensate

4. Coalescence and growth from vapor



Growth of Diamond on Ir (001)

SEM micrographs and 2D-Fourier transforms



The Ir surface is covered with diamond after 10 min growth.
(time after nucleation).

Early coalescence due to high nucleation density

Coalescence occurs after 20 min:
contraction of Fourier transform

Heteroepitaxial Single-Crystal Diamond

**3.5 mm diameter, 25 μm thickness
good optical quality**



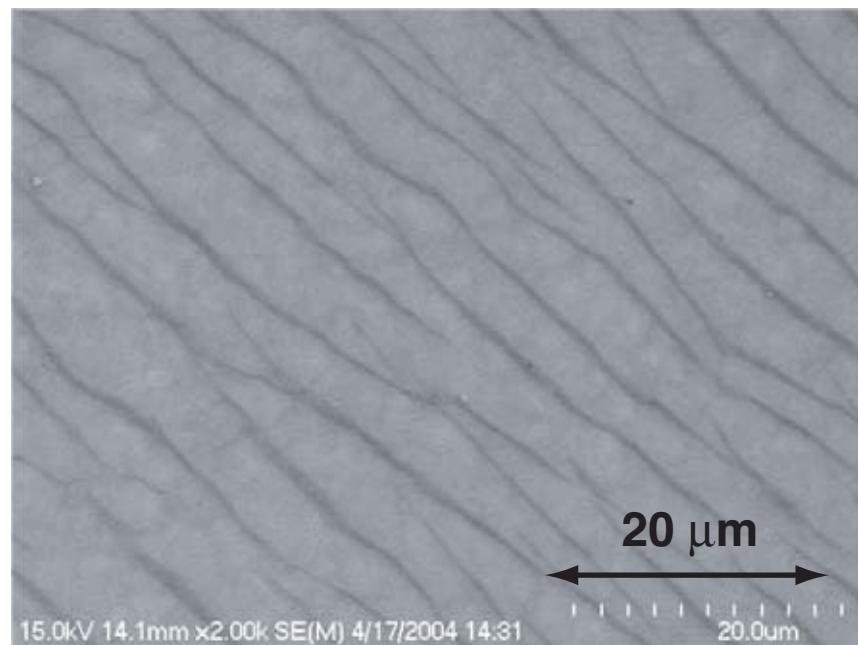
**CVD on Ir/SrTiO₃, surface (001)
growth time 37.5 hrs**

**Commercial
polycrystalline**

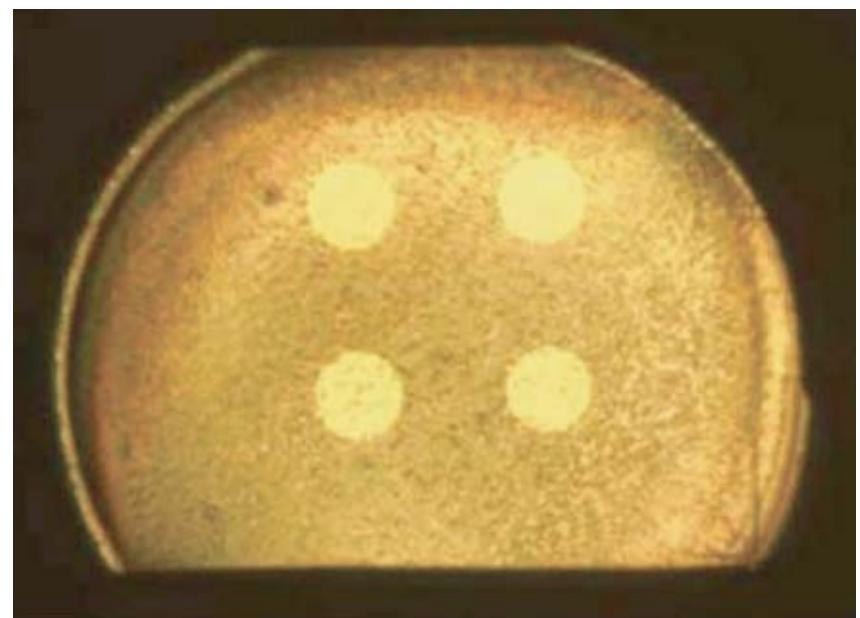


Heteroepitaxial SC diamond

Scanning electron microscope image
of the (001) diamond surface



optical photograph
with electrodes



step bunching, parallel to [110]
growth by step-flow mode,
pinning due to imperfections

-> investigated use for
particle detectors